## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SU ET AL. Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0155507	10-2002	Bruchez et al.	435/7.2
	В	US-2003/0211488	11-2003	Mirkin et al.	435/6
	С	US-6,699,724	03-2004	West et al.	436/525
	D	US-6,623,977	09-2003	Farquharson et al.	436/164
	E	US-6,149,868	11-2000	Natan et al.	422/82.05
	F	US-2002/0142480	10-2002	Natan, Michael J.	436/171
	G	US-6,485,703	11-2002	Cote et al.	424/9.1
	Н	US-6,514,767	02-2003	Natan, Michael J.	436/166
	ı	US-2003/0073139	04-2003	Kreimer et al.	435/7.9
	J	US-6,485,703	11-2002	Cote et al.	424/9.1
	·K	US-2003/0073139	04-2003	Kreimer et al.	435/7.9
	٦	US-6,514,767	02-2003	Natan, Michael J.	436/166
	М	US-6,586,502	07-2003	Wallace et al.	523/220

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	T			`		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	W			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.